

<b>Notice of References Cited</b>	Application/Control No. 10/602,614	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner Callie E. Shosho	Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 1059341 A1	12-2000	<u>        </u>	NAKANO et al.	<u>        </u>
	O	EP 1113051 A1	07-2001	<u>        </u>	HIDAKA et al.	<u>        </u>
	P					
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
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